56	earcn Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/090,138	LEVY ET AL.
Examiner	Art Unit
Kerri M. Dyke	2667

	SEAR	CHED	
Class	Subclass	Date	Examiner
370	229	1/18/2006	KMD
	232		
	237		
	252-254		
	351		
	389		
709	242		
	220-221		
	223		
	238-239		

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
	-		
			1

	RCH NOTES SEARCH STRATE	GY)
	DATE	EXMR
STIC PLUS	1/18/200	6 KMD
IEEE	1/19/200	6 KMD
ACM	1/19/200	06 KMD